

Polarization and Electroweak Precision Measurements at the ILC for $\sqrt{s} = 250$ GeV

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DER FORSCHUNG | DER LEHRE | DER BILDUNG

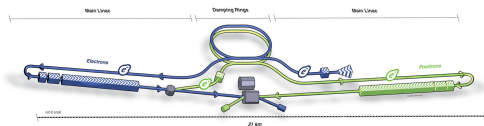


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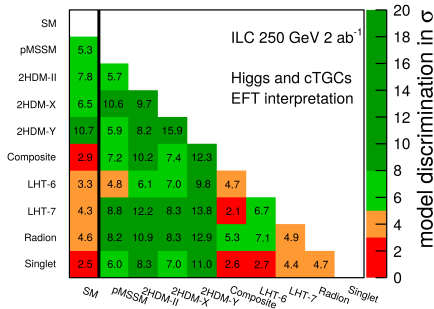
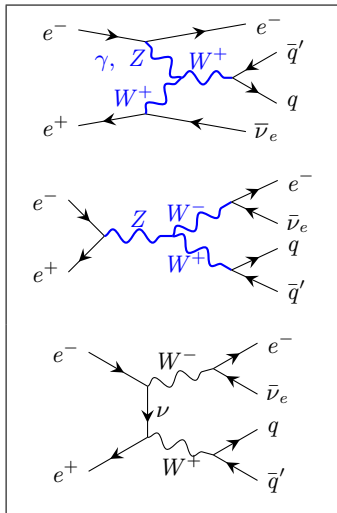
The International Linear Collider (ILC)



- ▶ Future linear e^+e^- Collider:
 $\sqrt{s} = 250$ GeV (As a first stage)
- ▶ Construction under political consideration in the Kitakami region, Prefecture Iwate, Japan
- ▶ **At the ILC both beams (e^+ , e^-) are polarized:** $P_{e^-} = \pm 80\%$, $P_{e^+} = \pm 30\%$
- ▶ **Switch of polarization sign (helicity reversal) \rightarrow choice of spin configuration**
- ▶ Designed for precision studies for physics of the standard model and beyond

Anomalous Triple Gauge Couplings (aTGCs)

$$e^+ e^- \rightarrow e \nu q \bar{q}$$

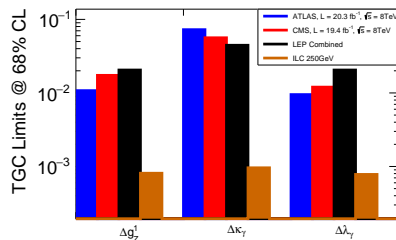


arXiv:1708.08912v1 [hep-ph]

- ▶ The TGC precision is important to distinguished different Higgs-models beyond the SM
- ▶ Additional bosons (e.g. Z') will affect TGCs
- ⇒ TGCs have to be precisely measured
- ⇒ aTGCs described by an Effective Field Theory (EFT)



Triple Gauge Couplings (TGC)



- ⇒ Polarization has to be known as precisely as the luminosity!
- ⇒ Requirement for a permille-level precision of the luminosity-weighted average polarization

Previously achieved polarization precision

$$\text{HERA: } \Delta P/P = 2\%_{\text{stat}} \oplus 1\%_{\text{sys}} \quad [1]$$

$$\text{SLAC: } \Delta P/P = 1.1\% \quad [2]$$

- ⇒ More than one order of magnitude better precision on both TGC and polarization measurement (for a start)
- ⇒ Accomplished by simultaneous measurement of both of them

Beam Polarization Dependent Cross Section

- ▶ Theoretical polarized cross section in general:

$$\begin{aligned}\sigma_{\text{theory}}(P_{e^-}, P_{e^+}) &= \frac{(1-P_{e^-})}{2} \frac{(1-P_{e^+})}{2} \cdot \sigma_{\text{LL}} + \frac{(1+P_{e^-})}{2} \frac{(1+P_{e^+})}{2} \cdot \sigma_{\text{RR}} \\ &+ \frac{(1-P_{e^-})}{2} \frac{(1+P_{e^+})}{2} \cdot \sigma_{\text{LR}} + \frac{(1+P_{e^-})}{2} \frac{(1-P_{e^+})}{2} \cdot \sigma_{\text{RL}}\end{aligned}$$

- ▶ Nominal ILC polarization values

$$\underbrace{P_{e^-}^- = -80\%}_{\text{"left"-handed } e^- \text{-beam}}$$

$$\underbrace{P_{e^-}^+ = 80\%}_{\text{"right"-handed } e^- \text{-beam}}$$

$$\underbrace{P_{e^+}^- = -30\%}_{\text{"left"-handed } e^+ \text{-beam}}$$

$$\underbrace{P_{e^+}^+ = 30\%}_{\text{"right"-handed } e^+ \text{-beam}}$$

- ▶ Cross section of the 4 polarization configurations

$$\sigma_{--} := \sigma(P_{e^-}^-, P_{e^+}^-)$$

$$\sigma_{++} := \sigma(P_{e^-}^+, P_{e^+}^+)$$

$$\sigma_{-+} := \sigma(P_{e^-}^-, P_{e^+}^+)$$

$$\sigma_{+-} := \sigma(P_{e^-}^+, P_{e^+}^-)$$

- ▶ $\sigma_{\text{LL}}, \sigma_{\text{RR}}, \sigma_{\text{LR}}, \sigma_{\text{RL}}$ are theoretically calculated including ISR and beam spectrum



Polarized Cross Section Measurement

- ▶ Measured polarized cross section:

$$\sigma_{\text{data}} = \frac{D - \mathfrak{B}}{\varepsilon \cdot \mathcal{L}}$$

D : Number of signal events

\mathfrak{B} : Background expectation value

ε : Detector selection efficiency

\mathcal{L} : Integrated luminosity

Remark:

All of them can vary between the different data sets (σ_{-+} , σ_{+-} , σ_{--} , σ_{++})

- ▶ Uncertainty of the polarized cross section is calculated via error propagation

$$\text{e.g. } (\Xi_{\mathcal{L}})_{ij} = \text{corr}(\sigma_i^{\mathcal{L}}, \sigma_j^{\mathcal{L}}) \frac{\partial \sigma_i}{\partial \mathcal{L}_i} \frac{\partial \sigma_j}{\partial \mathcal{L}_j} \Delta \mathcal{L}_i \Delta \mathcal{L}_j \quad i, j \in \{-+, +-, --, ++\}$$

$$\Xi := \underbrace{\Xi_D}_{\text{statistical uncertainty}} + \underbrace{\Xi_{\mathfrak{B}} + \Xi_{\varepsilon} + \Xi_{\mathcal{L}}}_{\text{systematic uncertainty}}$$

Remark:

Statistical uncertainty is always uncorrelated: $\text{corr}(\sigma_i^D, \sigma_j^D) \equiv \delta_{ij}$

And it is determined by Poisson fluctuations:

$$\Delta D \equiv \sqrt{D}$$

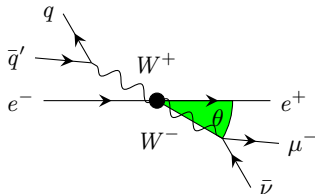


Usage of the Differential Polarized Cross Section

Choice of the angle:

- ✓ Individual for each channel
- ✓ High dependence of the angular distribution on the chiral structure
- ✓ Angle has to be well measurable
- ✓ Multi-angle distribution available

e.g.: $e^+e^- \rightarrow W^+W^- \rightarrow q\bar{q}'\mu^-\bar{\nu}$



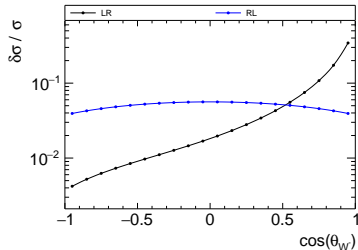
Bin-wise cross section calculation:

$$\underbrace{\frac{\partial\sigma}{\partial\theta}}_{\text{differential cross section}} \rightarrow \underbrace{\delta_i\sigma_{\text{data}}}_{\text{cross section of the } i\text{-th bin}} := \delta_i N / \mathcal{L}$$
$$\rightarrow \delta_i\sigma_{LR} := f_{LR}(\theta_i) \cdot \sigma_{LR}$$

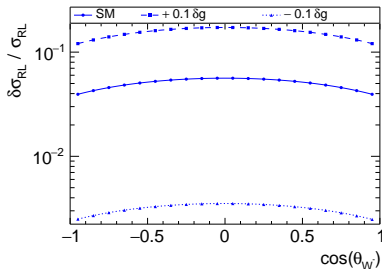
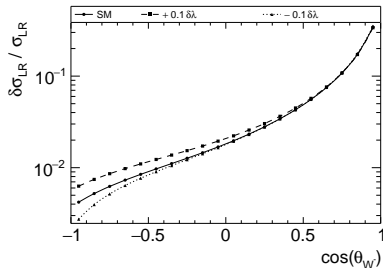
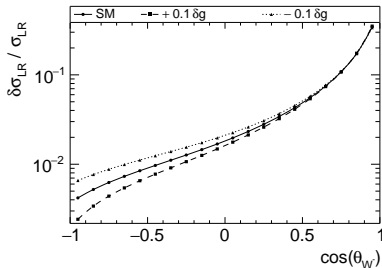
Analogue: RL , LL , RR

- ▶ $\delta_i N = (\delta_i D - \delta_i \mathfrak{B}) / \delta_i \mathcal{E}$: events of i -th bin
- ▶ $f(\theta_i)$: fraction of the total cross section

Projection on the θ_{W^-} -axis



Effect of Anomalous TGC in $e^-e^+ \rightarrow \mu\nu q\bar{q}$ at 250 GeV



- ▶ The effect of a $\pm 5\sigma$ deviation of a single TGC assuming LEP precision
- ▶ TGCs are a very small effect:
 - ▶ Especial affects angular ranges of low differential cross sections
 - But with a clear angular dependence
 - + Strong dependence of the chiral structure



- ▶ Using the method of least squares:

$$\chi^2 = \sum_{\text{channel}} \sum_i (\delta_i \vec{\sigma}_{\text{data}} - \delta_i \vec{\sigma}_{\text{theory}})^T (\delta_i \Xi)^{-1} (\delta_i \vec{\sigma}_{\text{data}} - \delta_i \vec{\sigma}_{\text{theory}});$$

$$\vec{\sigma} := (\delta_i \sigma_{-+} \quad \delta_i \sigma_{+-} \quad \delta_i \sigma_{--} \quad \delta_i \sigma_{++})^T$$

- ▶ Considered Channels and their Parameters:

channel	cross section	left-right asymmetry	TGC
$e^- e^+ \rightarrow e^- \bar{\nu} q \bar{q}$	$\sigma_{e^- \bar{\nu} q \bar{q}}$	$A_{RR}^{e^- \bar{\nu} q \bar{q}} = \frac{\sigma_{LR} - \sigma_{RR}}{\sigma_{LR} + \sigma_{RR}}$	$g_Z^1, \kappa_\gamma, \lambda_\gamma$
$e^- e^+ \rightarrow e^+ \nu q \bar{q}$	$\sigma_{e^+ \nu q \bar{q}}$	$A_{LL}^{e^+ \nu q \bar{q}} = \frac{\sigma_{LR} - \sigma_{LL}}{\sigma_{LR} + \sigma_{LL}}$	$g_Z^1, \kappa_\gamma, \lambda_\gamma$
$e^- e^+ \rightarrow \mu \nu q \bar{q}$	$\sigma_{\mu \nu q \bar{q}}$	$A_{RL}^{\mu \nu q \bar{q}} = \frac{\sigma_{LR} - \sigma_{RL}}{\sigma_{LR} + \sigma_{RL}}$	$g_Z^1, \kappa_\gamma, \lambda_\gamma$
$e^- e^+ \rightarrow \mu^+ \mu^- q \bar{q}$	$\sigma_{\mu \mu q \bar{q}}$	$A_{RL}^{\mu \mu q \bar{q}} = \frac{\sigma_{LR} - \sigma_{RL}}{\sigma_{LR} + \sigma_{RL}}$	-
$e^- e^+ \rightarrow q \bar{q}$	$\sigma_{q \bar{q}}$	$A_{RL}^{q \bar{q}} = \frac{\sigma_{LR} - \sigma_{RL}}{\sigma_{LR} + \sigma_{RL}}$	-
$e^- e^+ \rightarrow ll$	σ_{ll}	$A_{RL}^{ll} = \frac{\sigma_{LR} - \sigma_{RL}}{\sigma_{LR} + \sigma_{RL}}$	-

- ▶ $P_{e^-}^-, P_{e^-}^+, P_{e^+}^-, P_{e^+}^+$

determined globally for all channels



Results

Using the following parameter values:

$$\varepsilon = 0.6$$

$$\pi = \frac{D - \mathfrak{B}}{D} = 0.8$$

$$\mathcal{L} = 2 \text{ ab}^{-1}$$

$$\Delta\varepsilon = \Delta\pi = \Delta\mathcal{L} = 0$$

Luminosity sharing:

$$\begin{aligned} - + : 45\%, & \quad + - : 45\%, \\ - - : 5\%, & \quad + + : 5\% \end{aligned}$$

All results in $[10^{-4}]$

Cross Section

$\Delta\sigma_{e^+\nu q\bar{q}}/\sigma$	12.9
$\Delta\sigma_{e^-\bar{\nu}q\bar{q}}/\sigma$	13.3
$\Delta\sigma_{\mu\nu q\bar{q}}/\sigma$	11.4
$\Delta\sigma_{\mu\mu q\bar{q}}/\sigma$	13.8
$\Delta\sigma_{q\bar{q}}/\sigma$	3.78
$\Delta\sigma_{ll}/\sigma$	3.91

Asymmetry

$\Delta A_{RR}^{e^+\nu q\bar{q}}$	6.37
$\Delta A_{LL}^{e^-\bar{\nu}q\bar{q}}$	19.1
$\Delta A_{LR}^{\mu\nu q\bar{q}}$	3.32
$\Delta A_{LR}^{\mu\mu q\bar{q}}$	15.4
$\Delta A_{LR}^{q\bar{q}}$	6.66
ΔA_{LR}^{ll}	7.72

Polarization

$\Delta P_{e^-}^-$	7.68
$\Delta P_{e^-}^+$	3.4
$\Delta P_{e^+}^-$	8.11
$\Delta P_{e^+}^+$	10.7

TGC

Δg	8.18
$\Delta\kappa$	10.1
$\Delta\lambda$	9.33

- ▶ **Polarization provides a deep insight into the chiral structure of the standard model and beyond**
 - ▶ A permille-level precision of the luminosity-weighted average polarization at the IP is required
- ▶ **A full electroweak precision fit is achievable at the ILC**
 - ▶ The beam polarization, unpolarized cross section, the left-right asymmetry and anomalous Triple Gauge couplings can be determined with a relative precision of $\approx 10^{-3}$
- ▶ **Additional studies on the dependence of systematic quantities and their uncertainties will follow**



- [1] S. Baudrand, M Bouchela, V Brissona, R Chichea, M Jacqueta, S Kurbasova, G Lia, C Pascauda, A Rebouxa, V Soskova, Z Zhanga, F Zomera, M Beckinghamb, T Behnkeb, N Coppolab, N Meynersb, D Pitzlb, S Schmittb, M Authierc, P Deck-Betinellc, Y Queinecc and L Pinardd, *A high precision Fabry-Perot cavity polarimeter at HERA*, Journal of Instrumentation 2010,
(<http://www.slac.stanford.edu/cgi-wrap/getdoc/slac-pub-6700.pdf>)
- [2] P. C. ROWSON, *PRECISION ELECTROWEAK PHYSICS WITH THE SLD/SLC: THE LEFT-RIGHT POLARIZATION ASYMMETRY*, SLAC-PUB-6700, December 1994,
(<http://www.slac.stanford.edu/cgi-wrap/getdoc/slac-pub-6700.pdf>)

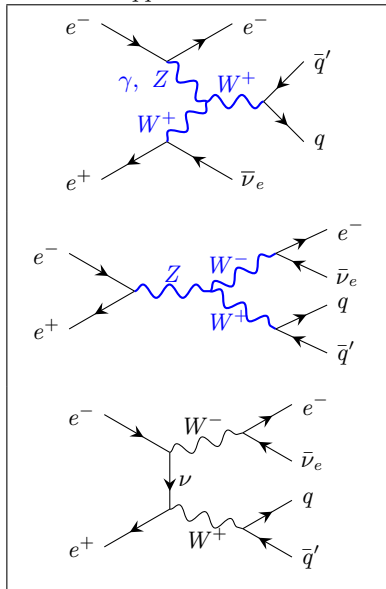


Backup Slides

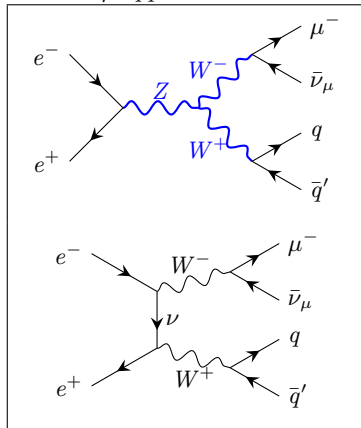


TGC Contribution for the Final State

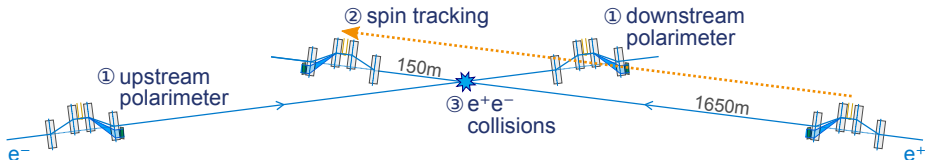
$$e^+e^- \rightarrow e\nu q\bar{q}$$



$$e^+e^- \rightarrow \mu\nu q\bar{q}$$



ILC Polarimetry Concept for Permilie-Level Polarization Precision



▶ The time-resolved beam polarization:

- ▶ Measured with 2 laser-Compton polarimeters before and after the e^-e^+ IP
- ▶ Polarimeter precision $\Delta P/P = 0.25\%$ from the start
- ▶ Extrapolated to the e^-e^+ IP via spin tracking

+ The luminosity-weighted averaged polarization:

- ▶ Calculated from collision data at the IP
- ▶ Using the cross section measurement of well known standard model processes

⇒ Combination of both measurements

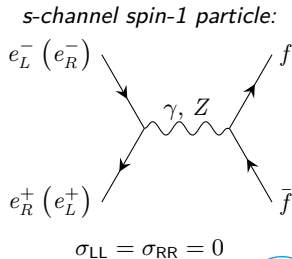
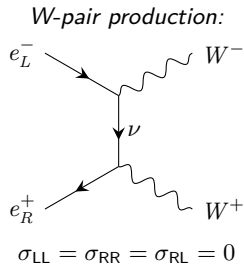
- With the aim to reach the permille-level precision $\Delta P/P = 0.1\%$

Physics Processes for Polarization Measurement

- ▶ Unpolarized cross section $\sigma_0 := \frac{1}{4} \sum \sigma$
 - ▶ Higher σ_0 increases the event rate
 - ▶ Left-right-asymmetry $A_{RL}^{LR} := \frac{\sigma_{LR} - \sigma_{RL}}{\sigma_{LR} + \sigma_{RL}}$
 - ▶ Sensitivity to the chiral structure
- ⇒ Both should be as high as possible

Examples at 500 GeV including ISR + Beamstrahlung:

Process	A_{RL}^{LR}	σ_0 [pb]
$e^+e^- \rightarrow W^+W^- \rightarrow q\bar{q}l\nu$	0.990	2.39
$e^+e^- \rightarrow Z \rightarrow q\bar{q}$	0.287	12.6
$e^+e^- \rightarrow e^-\bar{\nu}W^+ \rightarrow e^-\bar{\nu}q\bar{q}$	0.994	1.17
$e^+e^- \rightarrow e^+\nu W^- \rightarrow e^+\nu q\bar{q}$	0.994	1.17
⋮	⋮	⋮



- ▶ Measured polarized cross section:

$$\sigma_{\text{data}} = \frac{D - \mathfrak{B}}{\varepsilon \cdot \mathcal{L}}$$

D : Number of the measured signal events

\mathfrak{B} : Background expectation value

ε : Selection efficiency of the detector

\mathcal{L} : Integrated luminosity provided by the accelerator

Remark:

All of them can vary between the different data sets (σ_{--} , σ_{++} , σ_{-+} , σ_{+-})

- ▶ Uncertainty of the polarized cross section calculated via error propagation

$$\Delta\sigma^2 = \underbrace{\left(\frac{\partial\sigma}{\partial D}\Delta D\right)^2}_{\text{statistical uncertainty}} + \underbrace{\left(\frac{\partial\sigma}{\partial\mathfrak{B}}\Delta\mathfrak{B}\right)^2 + \left(\frac{\partial\sigma}{\partial\varepsilon}\Delta\varepsilon\right)^2 + \left(\frac{\partial\sigma}{\partial\mathcal{L}}\Delta\mathcal{L}\right)^2}_{\text{systematic uncertainty}}$$



► **The 4 ILC polarization configurations**

$$\begin{aligned}\sigma_{-+} &:= \sigma(P_{e^-}^-, P_{e^+}^+) & \sigma_{+-} &:= \sigma(P_{e^-}^+, P_{e^+}^-) \\ \sigma_{--} &:= \sigma(P_{e^-}^-, P_{e^+}^-) & \sigma_{++} &:= \sigma(P_{e^-}^+, P_{e^+}^+)\end{aligned}$$

► **Defining χ^2 function:**

$$\chi^2 := \sum_{\text{processes}} \sum_{i,k} \left(\frac{\sigma_{i,k}^{\text{data}} - \sigma_{i,k}^{\text{theory}}(P_{e^-}^i, P_{e^+}^k)}{\Delta\sigma_{i,k}} \right)^2 \quad i, k \in \{+, -\}$$

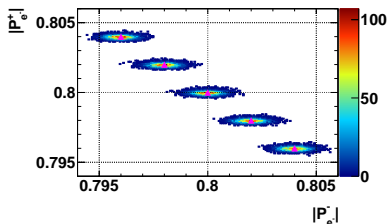
► **Determine the polarization:**

- Find $P_{e^-}^-, P_{e^-}^+, P_{e^+}^-, P_{e^+}^+$ that minimizes χ^2
- Parameter uncertainties provides also the polarization uncertainties:

$$\Delta P_{e^-}^-, \Delta P_{e^-}^+, \Delta P_{e^+}^-, \Delta P_{e^+}^+$$



Testing for a Non-Perfect Helicity Reversal



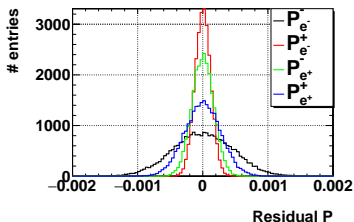
► Variation in the absolute polarization

- Toy Measurement for 5 different polarization discrepancies for both beams
- Nominal initial polarizations: $|P_{e^-}| = 80\%$, $|P_{e^+}| = 30\%$
- Statistical uncertainties only

► χ^2 -Fit:

- Correct determination of the 4 polarization values
- No noticeable impact on polarization precision using total cross sections

✓ **Can compensate for a non-perfect helicity reversal**



Consider Constraints from the Polarimeter Measurement

Simplified approach: (as a first step)

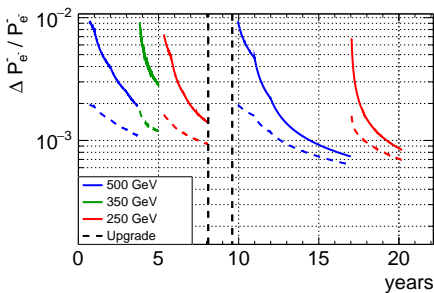
- ▶ Neglect spin transport
- ▶ Using $\Delta P/P = 0.25\%$:
- ▶ Gaussian distribution
 - ▶ Mean: $|P_{e^-}| = 80\%, |P_{e^+}| = 30\%$
 - ▶ Width: ΔP

Implementation:

$$\chi'^2 = \chi^2 + \sum_P \left[\frac{(P_{e^\pm}^\pm - \mathcal{P}_{e^\pm}^\pm)^2}{\Delta \mathcal{P}^2} \right]$$

- ▶ $P_{e^\pm}^\pm$: 4 fitted parameters
- ▶ $\mathcal{P}_{e^\pm}^\pm$: Polarimeter measurement
- ▶ $\Delta \mathcal{P}$: Polarimeter uncertainty

$E[\text{GeV}]$	500	350	250	500	250
$\mathcal{L}[1/\text{fb}]$	500	200	500	3500	1500
$[10^{-3}]$	Without Constraint				
$\Delta P_{e^-}^- / P$	1.9	2.8	1.4	0.74	0.84
$[10^{-3}]$	With Constraint				
$\Delta P_{e^-}^- / P$	1.1	1.2	0.93	0.63	0.69



- ▶ **Polarization provides a deep insight in the chiral structure of the standard model and beyond**
 - ⇒ A permille-level precision of the luminosity-weighted average polarization at the IP is required

- ▶ **Permille-Level polarization precision is achieved by the combination of**
 - ▶ The time-resolved beam polarization measurement with laser-Compton polarimeters
 - + The luminosity-weighted averaged polarization determined from collision data

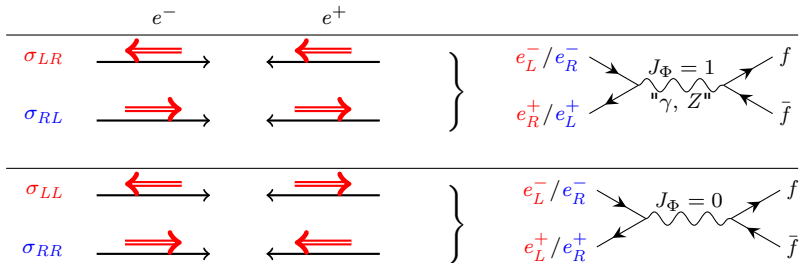
- ⇒ **With the combined method, the permille-level will be reached after ≈ 3 years of data taking**



Polarization at an e^-e^+ Collider

► Consider only one electron positron pair:

- Helicity is the projection of the spin vector on the direction of motion
- In case of massless particles, helicity is equal to chirality (left and right handedness)
- If $E_{\text{kin}} \gg E_0 \rightarrow m_e \approx 0$ e.g. ILC: $E_{\text{kin}}/E_0 \approx \mathcal{O}(10^5 - 10^6)$



► For a bunch of particles the polarization P is defined as:

$$P := \frac{N_R - N_L}{N_R + N_L} \quad \left\{ \begin{array}{l} N_R : \text{ The number of right-handed particles} \\ N_L : \text{ The number of left-handed particles} \end{array} \right.$$

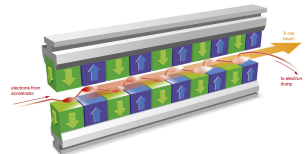
Production of Polarized Beams

Electron beam:

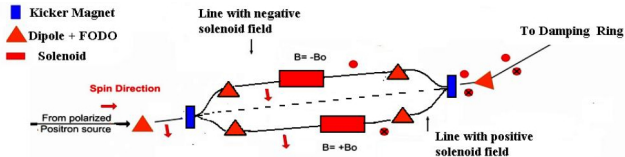
- ▶ Shooting of a circular polarized laser on a photocathode
- ▶ Switch between polarization signs (helicity reversal)
 - ⇒ Switch between signs of the laser polarization

Positron beam:

- ▶ Production of circular polarized γ 's from e^- -beam propagating through a helical undulator
 - ⇒ e^+ obtained via pair-production of the γ 's
- ▶ Helicity reversal
 - ⇒ Switch between two beam lines



www.xfel.eu/ueberblick/funktionsweise/



Laser-Compton Polarimeters

Spin Tracking

Collision Data

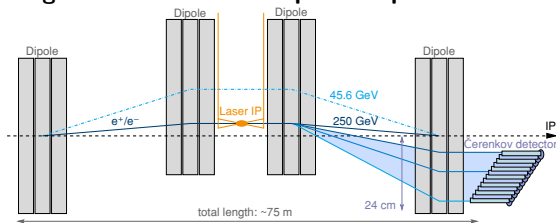
Improvement by Constraints from Polarimeter Measurement

Outlook



Laser-Compton Polarimeters

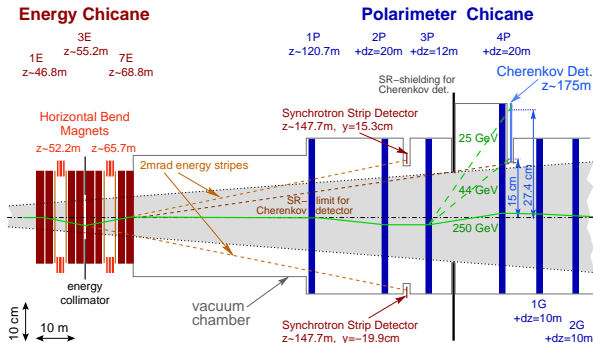
Magnetic chicane of the upstream polarimeters



- ▶ Compton scattering of the beam with a polarized Laser
- ▶ $\mathcal{O}(10^3)$ particles per bunch ($2 \cdot 10^{10}$) are scattered
- ▶ Magnetic chicane: energy spectrum \Rightarrow spatial distribution

- ▶ Energy spectrum measurement: \Rightarrow Counting the scattered particles at different positions
- ▶ Design of the magnetic Chicane:
 - ▶ Laser-bunch interaction point moves with beam energy \rightarrow position of the Compton edge stays the same
 - ▶ Orbit of the non-scattered particles is unaffected by the magnetic chicane

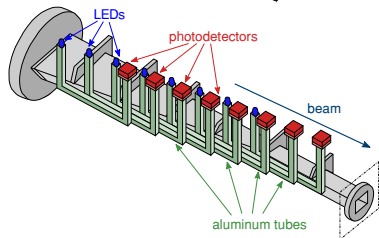
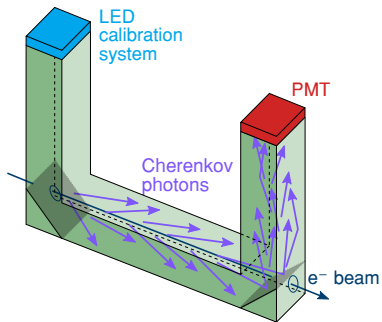
Downstream Polarimeter



Difference to Upstream Polarimeter due to a large disturbed beam

- ▶ Stronger banding of the beam after γ -IP
- ▶ 2 additional magnets to restore the beam orbit
- ▶ Measuring one bunch per train

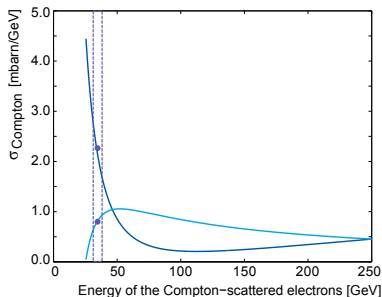
Cherenkov Detectors: Basic Concept



- ▶ U-shape channels filled with gas: e.g. perfluorobutane
- ▶ Concept
 - ▶ Scattered particles propagates through the bottom
 - ▶ Produced Cherenkov light is reflected to one end of the channel
 - ▶ Light measurement with photomultiplier tube (PMT)
- ▶ At the other end: LED for PMT calibration
- ▶ Sampling of the energy distribution
→ Number of Cherenkov detector
- ▶ Energy resolution
→ Thickness of a Cherenkov detector
- ▶ Quartz Cherenkov detector concept:
Ref.: Theses Annika Vauth

<http://bib-pubdb1.desy.de/record/171400>

Differential Compton Cross Section



Energy dependence:

$$\frac{d\sigma_C}{dy_C} = \frac{2\pi r_e^2}{x_C} (a_C + \lambda \mathcal{P} \cdot b_C); \quad y_C := 1 - \frac{E'}{E}$$

e^- Polarization: \mathcal{P} ; Laser Polarization: λ

DarkBlue: $\lambda \mathcal{P} = +1$

Cyan: $\lambda \mathcal{P} = -1$

Calculating \mathcal{P}_i of the i -th channel with asymmetry A_i , analysing power Π_i

$$A_i := \frac{N_i^- - N_i^+}{N_i^- + N_i^+}; \quad \Pi_i = \frac{\mathcal{I}_i^- - \mathcal{I}_i^+}{\mathcal{I}_i^- + \mathcal{I}_i^+}; \quad \mathcal{I}_i^\pm := \int_{E_i - \Delta/2}^{E_i + \Delta/2} \frac{d\sigma_C}{dy_C} \Big|_{\lambda \mathcal{P} = \pm 1} dy_C$$

$N_i^\pm := \# e_{\text{Compton}}$ for $\lambda \mathcal{P} = \pm 1$; E_i : energy of i -th channel; Δ : energy width

$$\Rightarrow \lambda \mathcal{P}_i = \frac{A_i}{\Pi_i} \quad \Rightarrow \quad \mathcal{P} = \langle \mathcal{P}_i \rangle$$



Compton Scattering Cross Section: Formulary

$$\frac{d\sigma}{dy_C} = \frac{2\pi r_e^2}{x_C} (a_C + \lambda \mathcal{P} \cdot b_C)$$

$$y_C := 1 - \frac{E'_\gamma}{E}; \quad x_C := \frac{4EE_\gamma}{m_e^2} \cos^2\left(\frac{\vartheta_0}{2}\right)$$

$$r_C := \frac{y_C}{x_C(1-y_C)}$$

$$a_C := (1-y_C)^{-1} + 1 - y_C - 4r_C(1-r_C)$$

$$b_C := r_C x_C (1 - 2r_C) (2 - y_C)$$

E, E_γ : e^-, γ energy before Compton scattering

E', E'_γ : e^-, γ energy after Compton scattering

m_e, r_e : mass, classical radius of e^-

ϑ_0 : crossing angle between e^-, γ

\mathcal{P} : longitudinal polarization of e^-

λ : circular polarization of γ_{Laser}

Characteristic Point:

$$E'_{\text{crossover}} = \frac{E}{1 + x_C/2},$$

$$E'_{\text{ComptonEdge}} = E'_{\text{min}} = \frac{E}{1 + x_C}$$



Laser-Compton Polarimeters

Spin Tracking

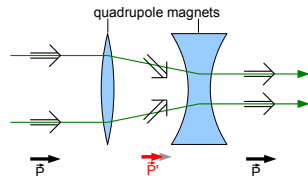
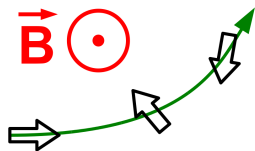
Collision Data

Improvement by Constraints from Polarimeter Measurement

Outlook



Spin Precession



- ▶ Polarimeters are 1.65 km and 150 m away from IP
 - Particles propagate through magnets
 - Magnets influence the spin, as well
 - Described by Thomas precession

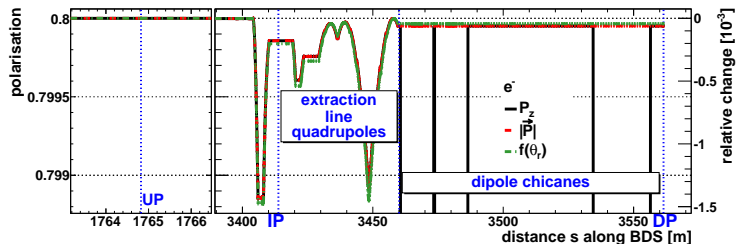
- ▶ if $\vec{B}_{\parallel} = \vec{E} = 0$:

$$\frac{d}{dt} \vec{S} = -\frac{q}{m\gamma} \left((1 + a\gamma) \vec{B}_{\perp} \right) \times \vec{S}$$

- ▶ Effects from focusing and defocusing can cancel
- ▶ For a series of quadrupole magnets \mathcal{P} described by the angular divergence θ_r

$$f(\theta_r) = |\vec{\mathcal{P}}|_{\max} \cdot \cos((1 + a\gamma) \cdot \theta_r)$$

Spin Tracking



Further causes of longitudinal beam polarization change:

- ▶ *Bremsstrahlung*:
Deceleration by passing through matter \longrightarrow negligible for colliders
- ▶ *Beamstrahlung*:
Deflection by the em-field of the oncoming bunch during collision
- ▶ *Synchrotron radiation*:
Deflection by the em-field of accelerator magnets

Systematic Polarization Uncertainty

contribution	uncertainty [10^{-3}]
Beam and polarization alignment at polarimeters and IP ($\Delta\vartheta_{\text{bunch}} = 50 \mu\text{rad}$, $\Delta\vartheta_{\text{pol}} = 25 \text{mrad}$)	0.72
Variation in beam parameters (10% in the emittances)	0.03
Bunch rotation to compensate the beam crossing angle	< 0.01
Longitudinal precession in detector magnets	0.01
Emission of synchrotron radiation	0.005
Misalignments (10 μ) without collision effects	0.43
Total (quadratic sum)	0.85
Collision effects in absence of misalignments	< 2.2

[Ref.:] Thesis Moritz Beckmann (<http://bib-pubdb1.desy.de/record/155874>)



Laser-Compton Polarimeters

Spin Tracking

Collision Data

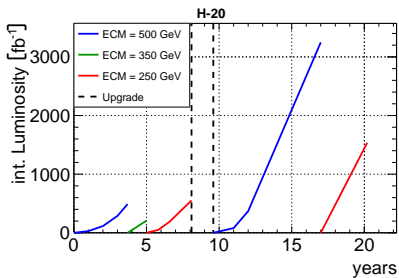
Consider Angular Information by Using differential Cross Section

Improvement by Constraints from Polarimeter Measurement

Outlook



Reference ILC Running Scenario: H-20



- ▶ Each run have its own polarization measurement
- ⇒ H-20: 5 polarization measurements
- ▶ All plots will refer to ILC nominal energy of 500 GeV

\sqrt{s} GeV	(-, +)	(+, -)	(-, -)	(+, +)	$\int L dt$ [fb ⁻¹]
	[%]	[%]	[%]	[%]	
250	67.5	22.5	5	5	2000
350	67.5	22.5	5	5	200
500	40	40	10	10	4000



Special Case: The Modified Blondel Scheme (MBS)

► Constraints for the Modified Blondel Scheme:

- Process must fulfill: $\sigma_{LL} \equiv \sigma_{RR} \equiv 0$
- Perfect helicity reversal: $+|P| \longleftrightarrow -|P| \Rightarrow |P| \equiv \text{const.}$

► Unique solution:

4 possible cross section measurements: $\sigma_{-+}, \sigma_{+-}, \sigma_{--}, \sigma_{++}$

Maximal 4 unknown quantities: $\sigma_{LR}, \sigma_{RL}, |P_{e-}|, |P_{e+}|$

► Solve for $|P_{e\mp}|$:

$$\sigma_{\pm\pm} = \frac{(1\pm|P_{e-}|)}{2} \frac{(1\mp|P_{e+}|)}{2} \cdot \sigma_{RL} + \frac{(1\mp|P_{e-}|)}{2} \frac{(1\pm|P_{e+}|)}{2} \cdot \sigma_{LR}$$

► Modified Blondel-Scheme:

$$|P_{e\mp}| = \sqrt{\frac{(\sigma_{-+} + \sigma_{+-} - \sigma_{--} - \sigma_{++}) (\pm\sigma_{-+} \mp \sigma_{+-} + \sigma_{--} - \sigma_{++})}{(\sigma_{-+} + \sigma_{+-} + \sigma_{--} + \sigma_{++}) (\pm\sigma_{-+} \mp \sigma_{+-} - \sigma_{--} + \sigma_{++})}}$$

► Uncertainties are calculated via analytic error propagation



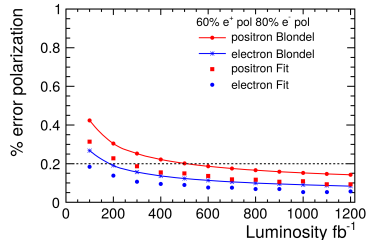
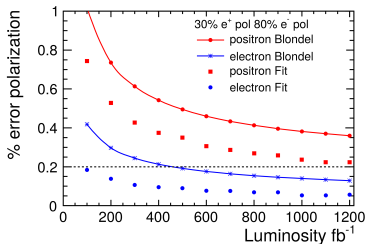
Previous W-Pair Study by Ivan Marchesini

W-Pair Production:

- ▶ Using $e^-e^+ \rightarrow W^+W^- \rightarrow q\bar{q}lv$
- ▶ Statistical uncertainties only
- ▶ Consider equal absolute polarizations
- ▶ Including full background study

Analyses techniques: (overview)

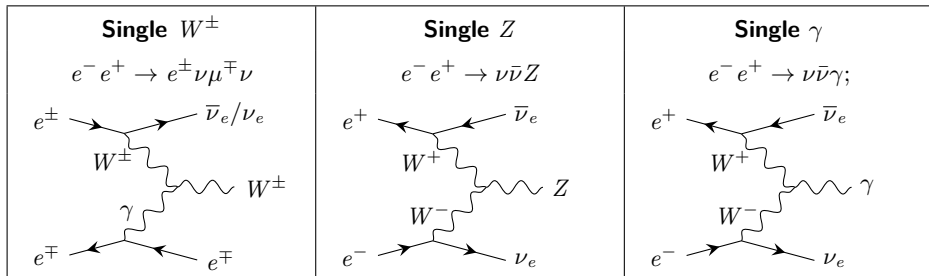
- ▶ Modified Blondel Scheme
- ▶ Angular Fit:
 - ▶ Using a χ^2 -minimization
 - ▶ Considering the production at different angles
 - ▶ Studied effects on deviations of the absolute polarization value
 - ▶ Measurement of triple gauge couplings



Ref.: Theses Ivan Marchesini

(<http://pubdb.xfel.eu/record/94888>)



Previous Single W^\pm , Z , γ Study by Graham W. Wilson

#	P	$\Delta P/P$
2	P_{e^-}	0.07%
	P_{e^+}	0.22%
4	P_{e^-}	0.085%
	δ_{e^-}	0.12%
	P_{e^+}	0.22%
	δ_{e^+}	0.32%

► Using a χ^2 -minimization

- Total cross sections only
- Simultaneous cross section measurement
- Using 4 processes simultaneously

- Only statistical error with fiducial cuts on cross sections
- Measuring absolute polarization deviation

Ref.: Talk Graham W. Wilson (<https://agenda.linuxcollider.org/event/5468/contributions/24027/>)



Current Work on the Determination of the Polarization from Collision Data

Goal:

General strategy for the polarization determination which yields the best precision per measurement time

- ▶ General and flexible method combining all relevant processes
- ▶ Including all uncertainties and their correlations
- ▶ Compensating for a non-perfect helicity reversal
- ▶ Considering the additional information from the angular distributions
- ▶ Using constraints from the polarimeter measurement for further improvement



Expected Polarized Cross Section

- ▶ Theoretical polarized cross section in general:

$$\begin{aligned} \sigma_{\text{theory}}(P_{e^-}, P_{e^+}) = & \frac{(1-P_{e^-})}{2} \frac{(1-P_{e^+})}{2} \cdot \sigma_{\text{LL}} + \frac{(1+P_{e^-})}{2} \frac{(1+P_{e^+})}{2} \cdot \sigma_{\text{RR}} \\ & + \frac{(1-P_{e^-})}{2} \frac{(1+P_{e^+})}{2} \cdot \sigma_{\text{LR}} + \frac{(1+P_{e^-})}{2} \frac{(1-P_{e^+})}{2} \cdot \sigma_{\text{RL}} \end{aligned}$$

- ▶ Nominal ILC Polarization values

$$\underbrace{P_{e^-}^- = -80\%}_{\text{"left"-handed } e^- \text{-beam}}$$

$$\underbrace{P_{e^-}^+ = 80\%}_{\text{"right"-handed } e^- \text{-beam}}$$

$$\underbrace{P_{e^+}^- = -30\%}_{\text{"left"-handed } e^+ \text{-beam}}$$

$$\underbrace{P_{e^+}^+ = 30\%}_{\text{"right"-handed } e^+ \text{-beam}}$$

- ▶ Cross section of the 4 polarization configurations

$$\sigma_{--} := \sigma(P_{e^-}^-, P_{e^+}^-)$$

$$\sigma_{++} := \sigma(P_{e^-}^+, P_{e^+}^+)$$

$$\sigma_{-+} := \sigma(P_{e^-}^-, P_{e^+}^+)$$

$$\sigma_{+-} := \sigma(P_{e^-}^+, P_{e^+}^-)$$



Comparison to Previous Analyses (Statistical Uncertainty Only)

E	500	250
\mathcal{L}	3500	1500
$P_{e^-}^-$	0.08	0.09
$P_{e^-}^+$	0.02	0.02
$P_{e^+}^-$	0.04	0.04
$P_{e^+}^+$	0.08	0.08

E	500	350	250
\mathcal{L}	500	200	500
$P_{e^-}^-$	0.2	0.3	0.1
$P_{e^-}^+$	0.05	0.06	0.03
$P_{e^+}^-$	0.1	0.1	0.06
$P_{e^+}^+$	0.2	0.3	0.1

Single boson:

- ▶ $\mathcal{L} = 2000 \text{ fb}^{-1}$, $E = 500 \text{ GeV}$
- ▶ No background estimation
- ▶ Fiducial cross section cuts
- ▶ Limitation on δ : $\Delta\delta < 10^{-3}$

$$P_{e^-} : 0.085\% \quad \delta_{e^-} : 0.12\%$$

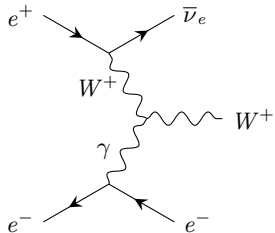
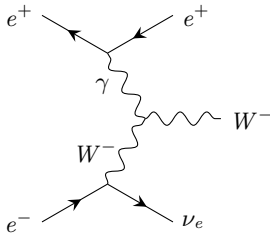
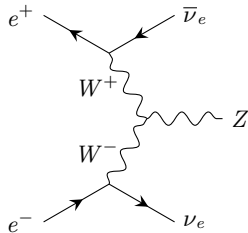
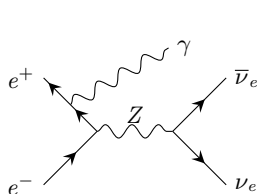
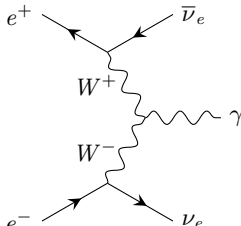
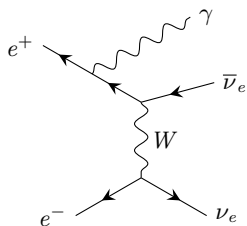
$$P_{e^+} : 0.22\% \quad \delta_{e^+} : 0.32\%$$

W-pairs:

- ▶ $\mathcal{L} = 500 \text{ fb}^{-1}$, $E = 500 \text{ GeV}$
- ▶ Full background estimation
- ▶ Differential cross section (angular fit)
- ▶ Only using 2 free parameters

$$P_{e^-} : 0.08\% \quad P_{e^+} : 0.34\%$$



Previous Single W^\pm , Z , γ Study: Leading DiagramsSingle W^+ Single W^- Single Z Single γ 

Comparison to the Previous W-Pair Study

Study by Ivan Marchesini:

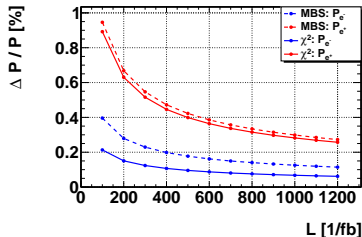
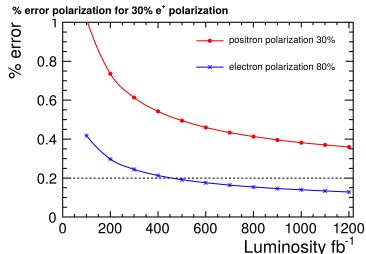
- ▶ Using $e^-e^+ \rightarrow W^+W^- \rightarrow q\bar{q}l\nu$
- ▶ Statistical uncertainties only
- ▶ Consider equal absolute polarizations (MBS)
- ▶ Including full background study

Adjustment of the current study:

- ▶ Limited to $e^-e^+ \rightarrow W^+W^- \rightarrow q\bar{q}l\nu$
- ▶ Forced equal absolute polarizations ($|P^L| \equiv |P^R|$)
- ▶ Including same background estimation and selection efficiency

Comparison:

- ⇒ χ^2 -method yields better precision under same conditions than the MBS



Comparison to Previous Single W^\pm, γ, Z Study

Study by Graham W. Wilson

- Using 4 Processes simultaneously:

$$e^- e^+ \rightarrow \nu \bar{\nu} \gamma; \quad e^- e^+ \rightarrow \nu \bar{\nu} Z$$

$$e^- e^+ \rightarrow e^+ \nu W^- \rightarrow e^+ \nu \mu^- \bar{\nu}$$

$$e^- e^+ \rightarrow e^- \bar{\nu} W^+ \rightarrow e^- \bar{\nu} \mu^+ \nu$$

- Consider equal absolute polarizations
2 Parameters: P_{e^-}, P_{e^+}
- Consider deviations: 4 Parameters

$$P_{e^\pm}^L = -|P_{e^\pm}| + \frac{1}{2}\delta_\pm$$

$$P_{e^\pm}^R = |P_{e^\pm}| + \frac{1}{2}\delta_\pm$$

parameters		$\Delta P/P, \mathcal{L} = 2ab^{-1}$	
#	P	Previous	Current
2	P_{e^-}	0.07%	0.051%
	P_{e^+}	0.22%	0.21%
4	P_{e^-}	0.085%	0.088%
	δ_{e^-}	0.12%	0.19%
	P_{e^+}	0.22%	0.23%
	δ_{e^+}	0.32%	0.56%

\mathcal{L} equally distributed between $\sigma_{\pm\pm}$

Statistical precision only

Comparison to Current analysis

- Differences:

Previous: Constraint on δ : $\Delta\delta < 10^{-3}$

Current: direct fit of $P_{e^\pm}^{L,R}$

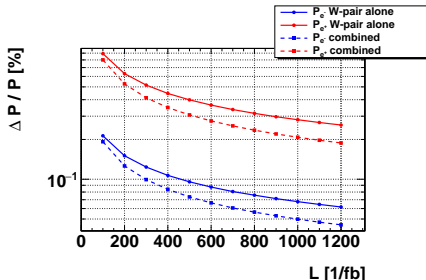
- Very similar precision even without additional constraint on δ



Combining W-Pair + Single W, Z, γ

Combined vs. W-Pairs alone

- ▶ W-Pair yields only enough information for 2 parameter fit P_{e^-}, P_{e^+}
 - ▶ Large improvement
→ due to additional processes
 - ▶ Combined: fit of 4 parameters is possible $P_{e^-}^L, P_{e^-}^R, P_{e^+}^L, P_{e^+}^R$
- ⇒ Compensation for a non-perfect helicity reversal



$$\Delta P/P, \mathcal{L} = 2ab^{-1}$$

Combined vs. Single Boson

- ▶ The 4 processes Single W^\pm , Single Z , Single γ yields a large analysis power
- ▶ Combined precision dominated by single boson processes

	single W, Z, γ	Combined
P_{e^-}	0.088%	0.079%
δ_{e^-}	0.19%	0.18%
P_{e^+}	0.23%	0.16%
δ_{e^+}	0.56%	0.51%



Polarized Cross Section Calculation: Basic Concept

Theory:

$$\begin{aligned} \sigma^{\text{theory}}(P_{e^-}, P_{e^+}) = & \\ & \frac{(1-P_{e^-})}{2} \frac{(1+P_{e^+})}{2} \cdot \sigma_{\text{LR}} \\ & + \frac{(1+P_{e^-})}{2} \frac{(1-P_{e^+})}{2} \cdot \sigma_{\text{RL}} \\ & + \frac{(1-P_{e^-})}{2} \frac{(1-P_{e^+})}{2} \cdot \sigma_{\text{LL}} \\ & + \frac{(1+P_{e^-})}{2} \frac{(1+P_{e^+})}{2} \cdot \sigma_{\text{RR}} \end{aligned}$$

Experiment:

$$\sigma^{\text{data}}(P_{e^-}, P_{e^+}) = \frac{N(P_{e^-}, P_{e^+})}{\mathcal{L}(P_{e^-}, P_{e^+})}$$

N : number of events

\mathcal{L} : integrated luminosity

Uncertainty via propagation of errors

$$\Delta\sigma^2 = \underbrace{\left(\frac{\partial\sigma}{\partial N}\Delta N\right)^2}_{\text{statistical uncertainty}} + \underbrace{\left(\frac{\partial\sigma}{\partial\mathcal{L}}\Delta\mathcal{L}\right)^2}_{\text{systematical uncertainty}}$$

Nominal ILC Polarization values

$$P_{e^-}^- = -80\%$$

"left"-handed e^- -beam

$$P_{e^-}^+ = 80\%$$

"right"-handed e^- -beam

$$P_{e^+}^- = -30\%$$

"left"-handed e^+ -beam

$$P_{e^+}^+ = 30\%$$

"right"-handed e^+ -beam



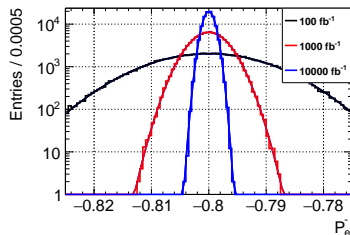
χ^2 -Minimization▶ Defining χ^2 function:

$$\chi^2 := \sum_{\text{process}} \sum_{\pm\pm} \frac{(\sigma_{\text{data}} - \sigma_{\text{theory}}(P_{e^-}^-, P_{e^-}^+, P_{e^+}^-, P_{e^+}^+))^2}{\Delta\sigma^2}$$

▶ Varying $(P_{e^-}^-, P_{e^-}^+, P_{e^+}^-, P_{e^+}^+)$ \rightarrow Minimizes χ^2

▶ Toy measurement:

- ▶ Signal expectation value:
 $\langle D \rangle = \sigma_{\text{theory}} \cdot \varepsilon \cdot \mathcal{L} + \mathfrak{B}$
- ▶ One toy experiment:
 Random Poisson number around each $\langle D \rangle$
- ▶ Determine $P_{e^\pm}^\pm$ by minimizing χ^2
- ▶ Simplified case for illustration:
 - ▶ $\mathfrak{B} = 0$ and $\varepsilon = 1$
 - ▶ Statistical uncertainties only
 - ▶ Using 10^5 toy measurements

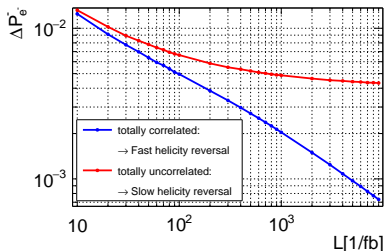


Systematic Uncertainties and their Correlations

▶ Systematic Uncertainties are influenced by

- ▶ Detector calibration and alignment
- ▶ Machine performance
- ▶ ...

⇒ Time dependent uncertainties



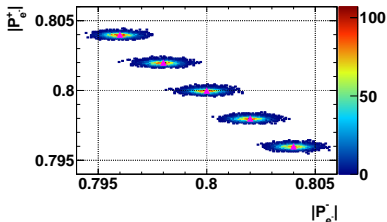
▶ Data set are taken one at a time:

- ▶ Slow frequency of helicity reversals: \mathcal{O} (weeks to months)
- ▶ Data sets are independent
- Completely uncorrelated
- ✗ Lead to saturation at systematic precision

▶ Data sets taken concurrently:

- ▶ Fast frequency of helicity reversals: \mathcal{O} (train-by-train)
- Faster than changes in calibration/alignment
- Generate correlations
- ✓ Lead to cancellation of systematic uncertainties

Testing for a Non-Perfect Helicity Reversal



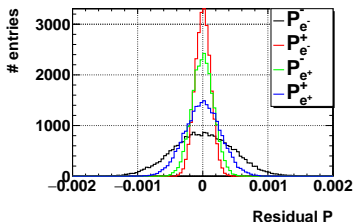
► Variation in the absolute polarization

- Toy Measurement for 5 different polarization discrepancies for both beams
- Nominal initial polarizations: $|P_{e^-}| = 80\%$, $|P_{e^+}| = 30\%$
- Statistical uncertainties only

► χ^2 -Fit:

- Correct determination of the 4 polarization values
- No noticeable impact on polarization precision using total cross sections

✓ Can compensate for a non-perfect helicity reversal



Theoretical Limit of the Statistical Precision

Consider most relevant processes:

Process	Channel
single W^\pm	$e\nu l\nu, e\nu q\bar{q}$
WW	$q\bar{q}q\bar{q}, q\bar{q}l\nu, l\nu l\nu$
ZZ	$q\bar{q}q\bar{q}, q\bar{q}ll, llll$
$ZZWW$ Mix	$q\bar{q}q\bar{q}, l\nu l\nu$
Z	$q\bar{q}, ll$

- ▶ Same processes as for physics analysis (DBD)
- ▶ Tree-level cross sections + ISR
- ▶ Any combination of processes can be used
- ▶ Further process can easily added

Consider best case scenario using σ_{tot} :

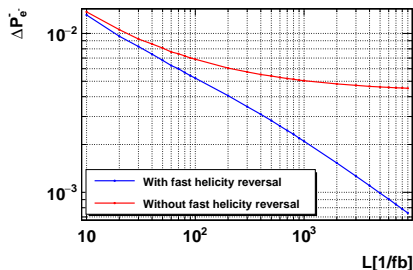
- ▶ Assumption of a perfect 4π detector
- ▶ No background
- ▶ No systematic uncertainties
- ▶ Using all considered processes

Statistical precision H-20: $\Delta P/P$ [%]

E	500	350	250	500	250
\mathcal{L}	500	200	500	3500	1500
$P_{e^-}^-$	0.2	0.3	0.1	0.08	0.09
$P_{e^-}^+$	0.05	0.06	0.03	0.02	0.02
$P_{e^+}^-$	0.1	0.1	0.06	0.04	0.04
$P_{e^+}^+$	0.2	0.3	0.1	0.08	0.08

Systematic Uncertainties and their Correlations

Systematic quantity		related to:
Integrated luminosity	\mathcal{L}	accelerator
Selection efficiency	ε	detector
Background estimate	\mathfrak{B}	theory



Remark:

A non-perfect helicity reversal has close to no influence on the precision due to compensation

► Uncertainties influenced by

- Detector calibration and alignment
- Machine performance
- \mathfrak{B} assumed constant and small
- ⇒ $\Delta\mathcal{L}$, $\Delta\varepsilon$ are time dependent

► One data set at a time:

- Data sets are independent
- Completely uncorrelated
- ⇒ Lead to saturation at systematic precision

► Fast helicity reversal:

- Data sets taken concurrently
- Generate correlations
- ⇒ Lead to cancellation of systematic uncertainties

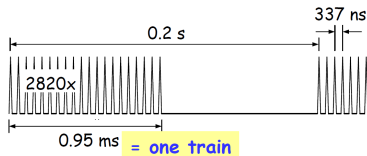


Generation of Correlated Uncertainties: Fast Helicity Reversal

Generation of Correlated Uncertainties

- ⇒ Change between data sets (σ_{-+} , σ_{+-} , σ_{--} , σ_{++}) faster than change in detector and accelerator calibration
- ⇒ Change between data sets during normal run without additional breaks

ILC Bunch Structure



Two possible frequency:

- ▶ bunch-by-bunch: switch between tow bunches
 - ▶ train-by-train: switch between two trains
- ▶ Technical feasibility much easier for train-by-train
 - ▶ Switch train-by-train should be sufficient for polarization precision
- ⇒ Precise correlation coefficient still to do

Implementing Correlated Uncertainties

$$\chi^2 = \sum_{\text{process}} (\vec{\sigma}_{\text{data}} - \vec{\sigma}_{\text{theory}})^T \Xi^{-1} (\vec{\sigma}_{\text{data}} - \vec{\sigma}_{\text{theory}}); \quad \vec{\sigma} := (\sigma_{-+} \quad \sigma_{+-} \quad \sigma_{--} \quad \sigma_{++})^T$$

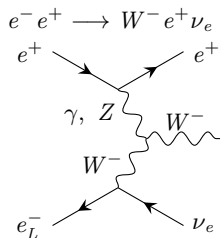
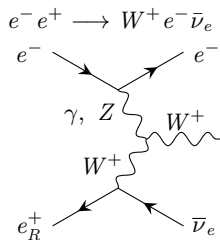
$$\Xi := \Xi_D + \Xi_{\mathfrak{B}} + \Xi_{\varepsilon} + \Xi_{\mathcal{L}}; \quad \text{e.g. } (\Xi_{\varepsilon})_{ij} = \text{corr}(\vec{\sigma}_i^{\varepsilon}, \vec{\sigma}_j^{\varepsilon}) \frac{\partial \vec{\sigma}_i}{\partial \varepsilon_i} \frac{\partial \vec{\sigma}_j}{\partial \varepsilon_j} \Delta \varepsilon_i \Delta \varepsilon_j$$

- ▶ Using the inverse covariance matrix Ξ^{-1}
- ▶ Correlation coefficients:
 - ▶ Identical for each process
 - ▶ Can be different for each quantity (\mathfrak{B} , ε , \mathcal{L})
 - ▶ Statistical uncertainties are always uncorrelated $\text{corr}(\vec{\sigma}_i^D, \vec{\sigma}_j^D) = 0 \quad \forall i \neq j$
 - ▶ Correlation coefficients are no free parameter
 ⇒ They are an external input parameter

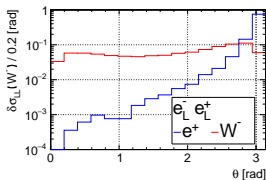
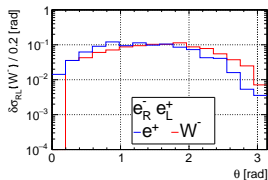
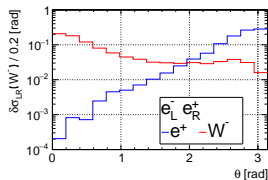
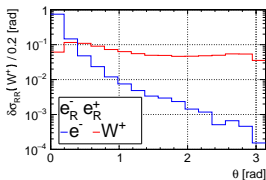
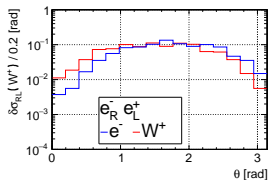
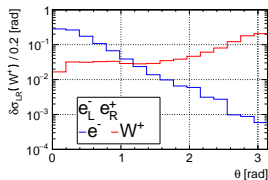


Consideration of the Addition Information from the Angular Distribution

- ▶ Total cross section
 - ▶ Rely on theoretical calculation
 - ⇒ Susceptible to BSM effects
- ▶ Differential cross section
 - ▶ Additional usage of the angular information
 - ⇒ Increase of the robustness against BSM effects
- ▶ Starting with Single W Process
 - ▶ Angular distribution has a large dependence on the chirality
 - ▶ Separated in W^+ and W^- production
 - ⇒ Sensitive to individual beam polarization
 - ▶ W^+ : only sensitive to P_{e^+}
 - ▶ W^- : only sensitive to P_{e^-}
- ▶ Further processes can easily be included



Single W^\pm : Polar Production Angle Distribution



► Single differential cross section: $\partial\sigma/\partial\theta$

► Two independent angles: θ_e, θ_W

► For now start with $\theta_e \rightarrow e^\pm$ also needed for separation between W^\pm

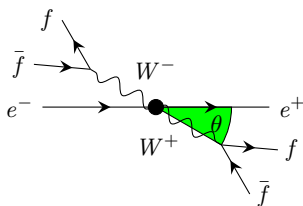
► $\partial\sigma/\partial\theta$ will be calculated via $\Delta\sigma_i/\Delta\theta_i$ ("cross section for the i -th bin in θ ")



Usage of the Differential Polarized Cross Section

- ▶ Total cross section
 - ▶ Rely on theoretical calculation
 - ⇒ Susceptible to BSM effects
- ▶ Differential cross section
 - ▶ Additional usage of the angular information
 - ⇒ Increase of the robustness against BSM effects

e.g.: $e^+e^- \rightarrow W^+W^- \rightarrow q\bar{q}l\nu$



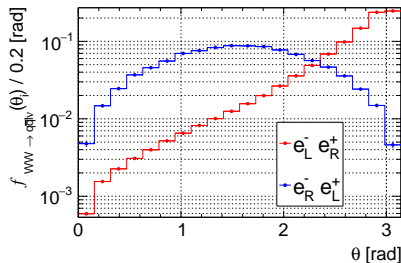
Bin-wise cross section calculation:

$$\underbrace{\frac{\partial\sigma}{\partial\theta}}_{\text{differential cross section}} \longrightarrow \underbrace{\delta_i\sigma_{\text{data}}}_{\text{cross section of the } i\text{-th bin}} := \delta_i N / \mathcal{L}$$

$$\longrightarrow \delta_i\sigma_{LR} := f_{LR}(\theta_i) \cdot \sigma_{LR}$$

Analog: RL, LL, RR

- ▶ $\delta_i N$: events of i -th bin
- ▶ $f(\theta_i)$: fraction of the total cross section



Defining Differential Cross Sections

Measured cross section:

$$\overbrace{\frac{\partial \sigma}{\partial \theta}}^{\text{differential cross section}} \longrightarrow \overbrace{\delta_i \sigma_{\text{data}}}^{\text{cross section per } i\text{th bin}} := \frac{\delta_i D - \delta_i \mathfrak{B}}{\delta_i \varepsilon \cdot \mathcal{L}}$$

$\delta_i D$	Number of signal events	}	of the i th bin
$\delta_i \mathfrak{B}$	Number of expected background events		
$\delta_i \varepsilon$	Selection efficiency		
\mathcal{L}	Integrated luminosity		

Theoretical cross section:

$$\begin{aligned} \delta_i \sigma_{\pm\pm} &= \frac{\binom{1\pm}{2} \binom{P_{e^-}^\pm}{2}}{\binom{1\pm}{2} \binom{P_{e^+}^\pm}{2}} \delta_i \sigma_{RR} + \frac{\binom{1\mp}{2} \binom{P_{e^-}^\pm}{2}}{\binom{1\mp}{2} \binom{P_{e^+}^\pm}{2}} \delta_i \sigma_{LL} \\ &+ \frac{\binom{1\pm}{2} \binom{P_{e^-}^\pm}{2}}{\binom{1\mp}{2} \binom{P_{e^+}^\pm}{2}} \delta_i \sigma_{RL} + \frac{\binom{1\mp}{2} \binom{P_{e^-}^\pm}{2}}{\binom{1\pm}{2} \binom{P_{e^+}^\pm}{2}} \delta_i \sigma_{LR} \\ \delta_i \sigma_{\text{theory}} &:= f(\theta_i) \cdot \sigma_{\text{theory}} \end{aligned}$$

$f(\theta_i)$ is directly obtained from the angular distributions



Implementing Differential Cross Sections in the χ^2 Minimization

Replacing: $\sigma \longrightarrow \delta_k \sigma +$ Sum over all bins

$$\chi^2 = \sum_{\text{process}} \sum_{\theta_k} (\delta_k \vec{\sigma}_{\text{data}} - \delta_k \vec{\sigma}_{\text{theory}})^T (\delta_k \Xi)^{-1} (\delta_k \vec{\sigma}_{\text{data}} - \delta_k \vec{\sigma}_{\text{theory}})$$

$$\delta_k \vec{\sigma} := \left(\delta_k \sigma_{-+} \quad \delta_k \sigma_{+-} \quad \delta_k \sigma_{--} \quad \delta_k \sigma_{++} \right)^T$$

$$\delta_k \Xi := \delta_k \Xi_N + \delta_k \Xi_{\mathfrak{B}} + \delta_k \Xi_{\varepsilon} + \delta_k \Xi_{\mathcal{L}};$$

$$(\delta_k \Xi_{\varepsilon})_{ij} = \text{corr}(\vec{\sigma}_i^{\varepsilon}, \vec{\sigma}_j^{\varepsilon}) \frac{\partial (\delta_k \vec{\sigma}_i)}{\partial (\delta_k \varepsilon_i)} \frac{\partial (\delta_k \vec{\sigma}_j)}{\partial (\delta_k \varepsilon_j)} \Delta (\delta_k \varepsilon_i) \Delta (\delta_k \varepsilon_j)$$

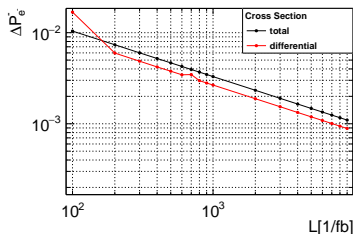
Remarks:

- ▶ Due to correlations, the binning in θ has to be equal for all cross sections
- ▶ It can differ between processes and decay-channels
- ▶ Range and number of bins of θ can be changed externally for each process



First Toy Measurements: Preliminary Results

Single W^\pm only

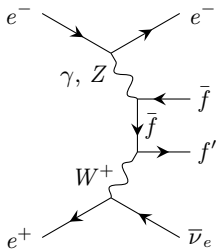
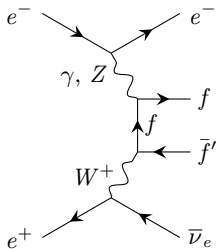
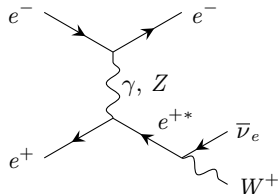
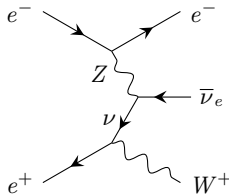
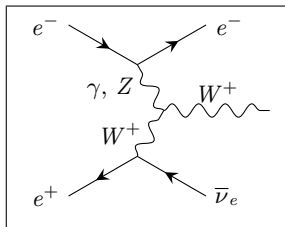


Using the following configuration:

- ▶ Using 16 equal bins in a θ range of $[0, \pi]$
 - ▶ Signal determination bin-by-bin:

$$\langle \delta_k D \rangle = \delta_k \sigma_{\text{theory}} \cdot \delta_k \varepsilon \cdot \mathcal{L} + \delta_k \mathfrak{B}$$
 - ▶ For the start:
 - Statistical error only + no background
 - ▶ Using H-20 integrated luminosity sharing due to energy
-
- ▶ Differential cross section have a lower statistic uncertainty:
 - ▶ Expectation of $\delta_k D$ can be for some bins $\mathcal{O}(1)$
 - ▶ Some zero diagonal entries of the covariance matrix \rightarrow not invertible
 - \Rightarrow Dropping χ^2 -terms with $\delta_k D = 0$
 - ▶ Further steps:
 - ▶ Optimizing the θ range and binning
 - ▶ Including further processes

Contributions to "Actual" Single W Production



Polarization dependence:

▶ Positrons:

⇒ only right-handed: e_R^+

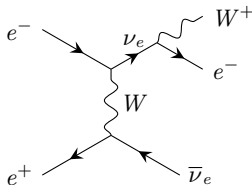
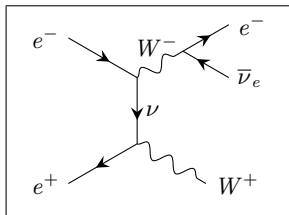
▶ Electrons:

▶ $e_L^- + e_R^-$

▶ difference for γ, Z

Further Contributions to Single W Production

Contribution from t-channel process:



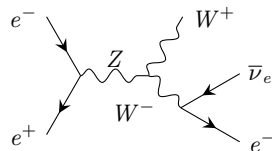
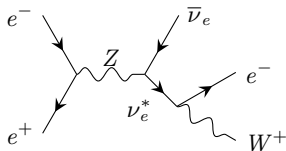
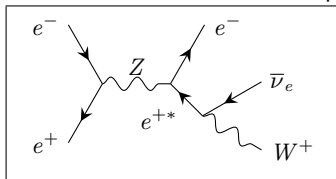
► t-channel contributions:

- W-pair production
- W exchange

► Polarization dependence:

- only e_R^+
- + only e_L^-

Contribution from s-channel Z process (only for opposite chirality):



E	500	350	250	500	250
\mathcal{L}	500	200	500	3500	1500
Without Constraint					
$P_{e^-}^-$	0.2	0.3	0.1	0.08	0.09
$P_{e^-}^+$	0.05	0.06	0.03	0.02	0.02
$P_{e^+}^-$	0.1	0.1	0.06	0.04	0.04
$P_{e^+}^+$	0.2	0.3	0.1	0.08	0.08
With Constraint					
$P_{e^-}^-$	0.1	0.1	0.1	0.07	0.07
$P_{e^-}^+$	0.04	0.05	0.03	0.02	0.02
$P_{e^+}^-$	0.09	0.09	0.05	0.04	0.03
$P_{e^+}^+$	0.1	0.1	0.09	0.07	0.07



Systematic Uncertainty Calculation

Selection Efficiency ε

- ▶ Realistic values for ε and $\Delta\varepsilon$ still missing
- ▶ ε values for:
 - ▶ W-pair production: Thesis Ivan
 - ▶ Single W: Accessible due to the work of our former intern Sebastian Garcia

Expected Background Prediction \mathfrak{B}

- ▶ Background estimate $\mathfrak{B} \pm \Delta\mathfrak{B}$ is also missing for each process
- ▶ Full background analysis for every process is not feasible
- ▶ $WW \rightarrow qq\nu\nu$: \mathfrak{B} can be taken from Ivan's thesis
 - ⇒ Assuming similar \mathfrak{B} for other boson pair



Simultaneous Fitting of chiral cross sections

Similar to G. Wilson's single boson study:

$$\begin{pmatrix} \sigma_{LR}^{\gamma} & \sigma_{LR}^Z & \sigma_{LR}^{\mu} & \sigma_{LR}^{\mu} \\ \sigma_{RL}^{\gamma} & 0.465 & 0.066 & 0.066 \\ 0.0 & 0.0 & \sigma_{SS}^{\mu} & 0.0 \\ 0.0 & 0.0 & 0.0 & \sigma_{SS}^{\mu} \end{pmatrix}$$

Ongoing Work for the current study:

- ▶ Implementing of free linear cross section scaling parameters
- ▶ Each chiral cross section can be scaled individually or fixed
- ▶ Chiral cross section can have the same scaling parameter
- ▶ Which cross section is scaled will be changeable

7-parameter single boson fit

2 ab⁻¹ equally distributed
(statistical errors only)

$$|P_{e-}| = 80.000 \pm 0.056\%$$

$$|P_{e-}| = 30.000 \pm 0.065\%$$

$$\sigma_{LR}^{\gamma} = 3098.0 \pm 2.7 \text{ fb}$$

$$\sigma_{RL}^{\gamma} = 25.3 \pm 1.1 \text{ fb}$$

$$\sigma_{LR}^Z = 159.40 \pm 0.57 \text{ fb}$$

$$\sigma_{LR}^{\mu} = 580.9 \pm 1.1 \text{ fb}$$

$$\sigma_{SS}^{\mu} = 657.4 \pm 1.1 \text{ fb}$$

Beam polarizations correlation:

$$\rho(|P_{e-}|, |P_{e-}|) = 14\%$$

